

**Notice of References Cited**

Application/Control No.

10/516,306

Applicant(s)/Patent Under  
Reexamination  
IGARASHI ET AL.

Examiner

Dzung D. Tran

Art Unit

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0002715	01-2006	Igarashi et al.	398/152
*	B	US-2003/0012495	01-2003	Islam et al.	385/31
*	C	US-5,523,874	06-1996	Epworth, Richard E.	398/28
*	D	US-2003/0118303	06-2003	Evans, Alan F.	385/122
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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